International TOR Rectifier

POWER MOSFET SURFACE MOUNT(SMD-1)

Product Summary

Part Number	RDS(on)	ΙD		
IRFN150	0.07 Ω	34A		

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

IRFN150 JANTX2N7224U JANTXV2N7224U REF:MIL-PRF-19500/592 100V, N-CHANNEL

HEXFET® MOSFETTECHNOLOGY



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Surface Mount
- Dynamic dv/dt Rating
- Light-weight

Absolute Maximum Ratings

	Parameter		Units	
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	34		
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	21	Α	
IDM	Pulsed Drain Current ①	136		
P _D @ T _C = 25°C	Max. Power Dissipation	150	W	
	Linear Derating Factor	1.2	W/°C	
VGS	Gate-to-Source Voltage	±20	V	
EAS	Single Pulse Avalanche Energy ②	150	mJ	
IAR	Avalanche Current ①	34	Α	
EAR	Repetitive Avalanche Energy ①	15	mJ	
dv/dt	Peak Diode Recovery dv/dt 3	5.5	V/ns	
TJ	Operating Junction	-55 to 150		
TSTG	Storage Temperature Range		°C	
	Package Mounting Surface Temperature	300(for 5 seconds)		
	Weight	2.6 (Typical)	g	

For footnotes refer to the last page

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	100	_	_	V	VGS = 0V, ID = 1.0mA
ΔBV _{DSS} /ΔT _J	Temperature Coefficient of Breakdown Voltage	_	0.13	_	V/°C	Reference to 25°C, I _D = 1.0mA
RDS(on)	Static Drain-to-Source On-State	_	_	0.07	Ω	VGS = 10V, ID = 21A
	Resistance	_	_	0.081	22	VGS = 10V, ID = 34A
VGS(th)	Gate Threshold Voltage	2.0	_	4.0	V	$V_{DS} = V_{GS}$, $I_{D} = 250\mu A$
9fs	Forward Transconductance	9.0	_	_	S (7)	V _{DS} > 15V, I _{DS} = 21A ④
IDSS	Zero Gate Voltage Drain Current	_	_	25	μА	VDS= 80V ,VGS=0V
		_	—	250	μΑ	$V_{DS} = 80V$,
						VGS = 0V, TJ = 125°C
IGSS	Gate-to-Source Leakage Forward	_	_	100	nA	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse	_	_	-100	l IIA	VGS = -20V
Qg	Total Gate Charge	_	_	125		VGS =10V, ID = 34A
Qgs	Gate-to-Source Charge	_	_	22	nC	V _{DS} = 50V
Q _{gd}	Gate-to-Drain ('Miller') Charge	_	_	65		
td(on)	Turn-On Delay Time	_	_	35		$V_{DD} = 50V, I_{D} = 34A,$
tr	Rise Time	_	_	190	ns	$V_{GS} = 10V$, $R_{G} = 2.35\Omega$
td(off)	Turn-Off Delay Time	_	_	170	115	
tf	Fall Time	_	_	130		
LS+LD	Total Inductance	_	4.0	_	nH	Measured from the center of drain
						pad to center of source pad.
C _{iss}	Input Capacitance		3700			$V_{GS} = 0V$, $V_{DS} = 25V$
Coss	Output Capacitance	_	1100		pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	_	200	_		

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
Is	Continuous Source Current ((Body Diode)	_	_	34		
ISM	Pulse Source Current (Body	Diode) ①	_	_	136	Α	
VSD	Diode Forward Voltage		_	_	1.8	V	$T_j = 25$ °C, $I_S = 34A$, $V_{GS} = 0V$ ④
t _{rr}	Reverse Recovery Time		_	_	500	nS	Tj = 25°C, IF = 34A, di/dt ≤ 100A/μs
QRR	Reverse Recovery Charge		_	_	2.9	μC	V _{DD} ≤ 30V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by Lg + LD.					

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	_	_	0.83	°C/W	
R _{th} J-PCB	Junction-to-PC board	_	3.0	_	C/VV	Soldered to a copper-clad PC board

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

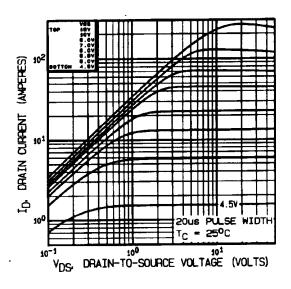


Fig 1. Typical Output Characteristics

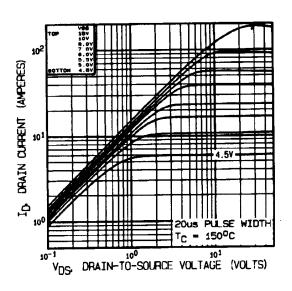


Fig 2. Typical Output Characteristics

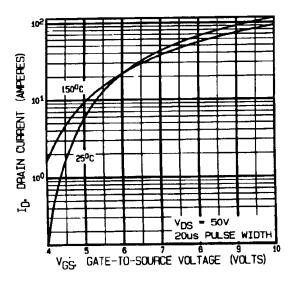


Fig 3. Typical Transfer Characteristics

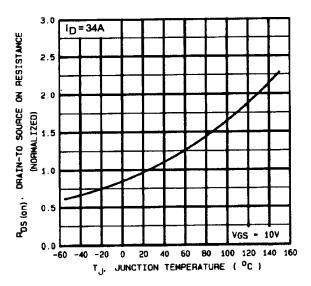
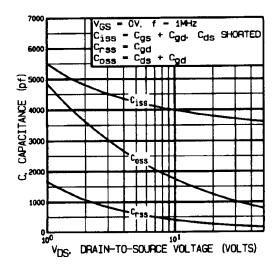


Fig 4. Normalized On-Resistance Vs. Temperature



1D = 34A

VDS = 80V

VDS = 50V

VDS = 50V

VDS = 20V

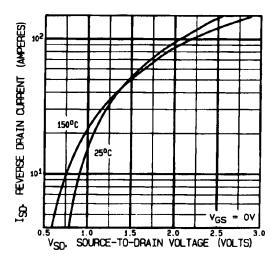
POR TEST CIRCUIT

SEE FIGURE 13a & b

Gg. TOTAL GATE CHARGE (nC)

Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage



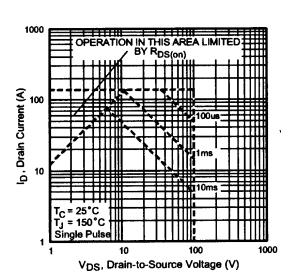


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

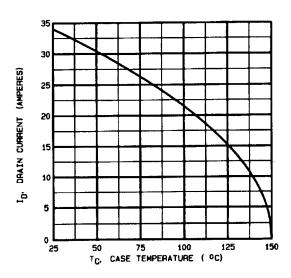


Fig 9. Maximum Drain Current Vs. Case Temperature

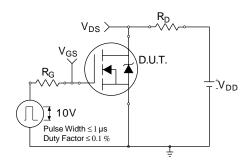


Fig 10a. Switching Time Test Circuit

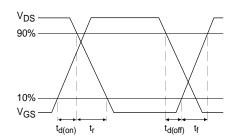


Fig 10b. Switching Time Waveforms

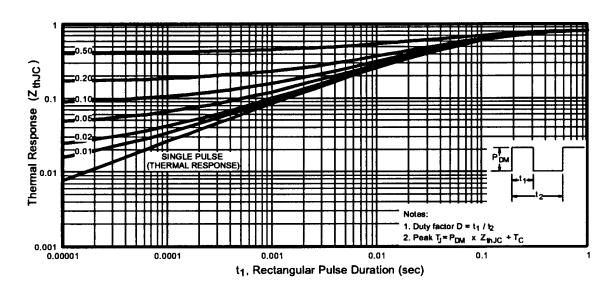


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

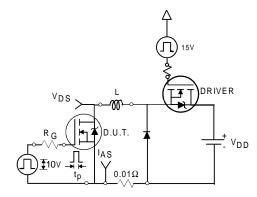


Fig 12a. Unclamped Inductive Test Circuit

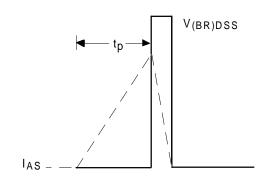


Fig 12b. Unclamped Inductive Waveforms

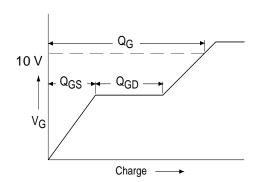


Fig 13a. Basic Gate Charge Waveform

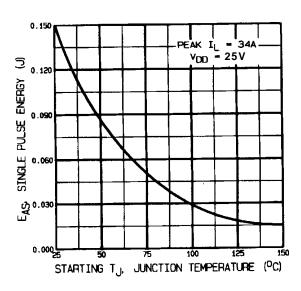


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

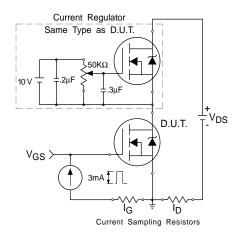


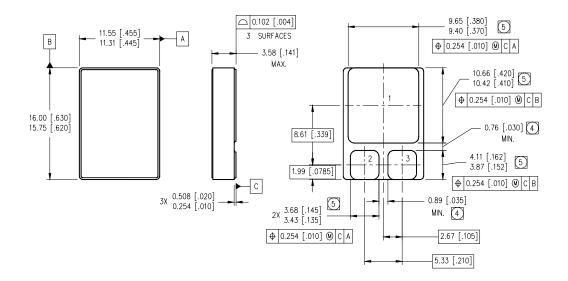
Fig 13b. Gate Charge Test Circuit

IRFN150

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\circ}$ V_{DD} = 25V, starting T_J = 25°C, L= 0.26mH Peak I_L = 34A, V_{GS} = 10V
- $\label{eq:local_local_state} \begin{array}{ll} \mbox{(3)} & \mbox{ISD} \leq 34\mbox{A, di/dt} \leq 200\mbox{A/}\mu\mbox{s,} \\ \mbox{VDD} \leq 100\mbox{V, TJ} \leq 150\mbox{°C} \\ \end{array}$
- ④ Pulse width ≤ 300 μ s; Duty Cycle ≤ 2%

Case Outline and Dimensions — SMD-1



NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4 DIMENSION INCLUDES METALLIZATION FLASH.
- 5) DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

PAD ASSIGNMENTS

- 1- DRAIN
- 2- GATE
- 3- SOURCE



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Visit us at www.irf.com for sales contact information. Data and specifications subject to change without notice. 01/02

单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon Technologies(英飞凌)